PA-IDC

QUERY CONTR	OL FORM	RTIS USE ONLY			
Application No.	09498608	Prepared by	ewi	Tracking Number	05874557
Examiner-GAU	Frech	Date	1/20/04	Week Date	12-15-63
	2876	No. of queries	-2-	IFW	

JACKET						
a. Serial No.	f. Foreign Priority	k. Print Claim(s)	p. PTO-1449			
b. Applicant(s)	g. Disclaimer	I. Print Fig.	q. PTOL-85b			
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract			
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs			
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other			

SPECIFICATION	MESSAGE
a. Page Missing	PIO-1449 Please either initial or
b. Text Continuity	MESSAGE PTO-1449 Please either initial or line through citations see attached. Dearched Column is blank. Please advise
c. Holes through Data	D Searched Column is blank.
d. Other Missing Text	please alvis ?
e. Illegible Text	Mank you
f. Duplicate Text	ρως
g. Brief Description	
h. Sequence Listing	
i. Appendix	
j. Amendments	
k. Other	
CLAIMS	
a. Claim(s) Missing	
b. Improper Dependency	
c. Duplicate Numbers	
d. Incorrect Numbering	initials
e. Index Disagrees	RESPONSE
f. Punctuation	
g. Amendments	
h. Bracketing	
i. Missing Text	
j. Duplicate Text	
k. Other	
	initials

		_)					Sheet 1 of 1
PATENT & TRADÉMARK		t. of Commerce MARK OFFICE	ATTY BOX	O7447.0016	APPLICAT 09	ion no. 1/498,609	
PE JOSE		N DISCLOSURE STATEM reral sheets if necessary)	ENT	APPLICAN	IT David L. Hecht et al.		
2 7000 mg		,,,		FILING DATE 2/4/2000		ROUP ART UNIT 2876	
3 8 -	9		U.S. PA	ENT DOCU	WENTS		
EXAMINENT	DO	CUMENT NUMBER	PUBLICAT DATE		NAME OF PATENTEE	CLAS	SUB CLASS
		5,951,056		9/14/99 Fukuda		283	93
		5,988,505	11/23/9	9	Shellhammer	235	462.09
					····		
			FOREIGN I	PATENT DO	CUMENTS		
COUNTRY DOCUMENT NUMBER EP 0 254 644 A2			ICATION DATE	NAME OF PATENTEE OR A	PLICANT	TRANSLATION Y/N	
		1/	27/88	Fairchild Semicondu Corporation	uctor	Y	
	EP	0 469 864 A	2	/5/92	Xerox Corporation	n	Y
	FP	0 923 050 42	6/	16/99	Affymetriy Inc		٧

	COUNTRY	DOCUMENT NUMBER	PUBLICATION DATE	NAME OF PATENTEE OR APPLICANT	TRANSLATION Y/N
	EP	0 254 644 A2	1/27/88	Fairchild Semiconductor Corporation	Y
	EP	0 469 864 A	2/5/92	Xerox Corporation	Y
	EP	0 923 050 A2	6/16/99	Affymetrix, Inc.	Y
<u> </u>			ļ		<u> </u>
			<u> </u>		
			<u></u>		

OTHER DOCUMENTS (Including Author (in CAPS), Title, Publication Date, Pages, etc.) EP Search Report for application EP 00 31 0774 (U.S. Counterparts 09/454,526; 09/455,304 and 09/456,105) dated July 18, 2003. EXAMINER DATE CONSIDERED

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.